Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/724,177	LIEN, WEN HUNG	
Examiner	Art Unit	
Chun-Kuan (Mike) Lee	2181	

SEARCHED					
Class	Subclass	Date	Examiner		
710	· 72	9/26/2007	CKL		
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated EAST search:US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT Updated Inventor search utilizing eDan and EAST	9/26/2007	CKL		
(710/72-74).ccls. limited text search	9/26/2007	CKL		
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